# 2SK2015

### Silicon N-Channel Power F-MOS

#### Features

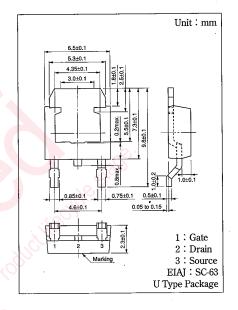
- Low ON-resistance  $R_{DS(on)}$ :  $R_{DS(on)}1=0.7 \Omega$  (typ)
- High-speed switching: t<sub>f</sub>=36ns(typ)
- No secondary breakdown
- For low-voltage drive (V<sub>GS</sub>=4V)
- Taping supply possible

#### Applications

- DC-DC converter
- Non-contact relay
- Solenoid drive
- Motor drive

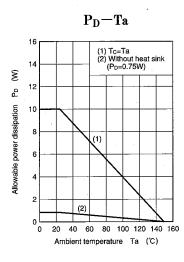
## ■ Absolute Maximum Ratings (T<sub>C</sub>=25°C)

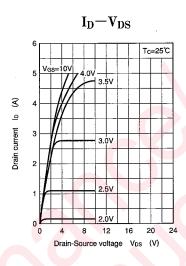
Paramete	Symbol	Rating	Unit		
Drain-Source breakdown voltage		$V_{\rm DSS}$	150	VO	
Gate-Source voltag	$V_{GSS}$	±20	V		
Drain current	at 4V drive	$I_{D}$	±3	A	
	Pulse	I <sub>DP</sub>	±6	Α	
Allowable power	T <sub>C</sub> =25℃	n	10	w	
dissipation	Ta=25℃	$P_{D}$	0.75		
Channel temperature		T <sub>ch</sub>	150	$^{\circ}\mathbb{C}$	
Storage temperature		T <sub>stg</sub>	-55  to  +150	$^{\circ}$	
		0.9	70 :11	~(),	

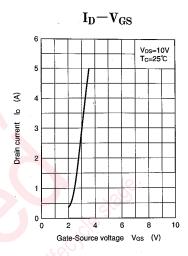


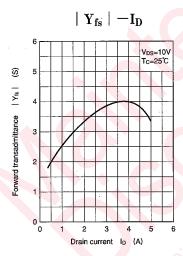
### ■ Electrical Characteristics (T<sub>C</sub>=25°C)

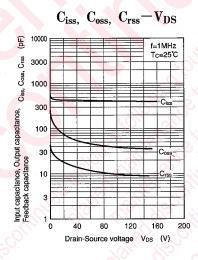
Parameter	Symbol	Condition	Min	Тур	Max	Unit
Drain-Source cut-off current	$I_{DSS}$	$V_{DS} = 130V, V_{GS} = 0$			10	$\mu$ A
Gate-Source leakage current	I <sub>GSS</sub>	$V_{GS}=\pm 20V$ , $V_{DS}=0$		t	±1	$\mu$ A
Drain-Source breakdown voltage	V <sub>DSS</sub>	$I_D=1$ mA, $V_{GS}=0$	150			v
Gate threshold voltage	V <sub>th</sub>	$V_{DS}=10V$ , $I_{D}=1mA$	1		2.5	V
Drain-Source ON-resistance	R <sub>DS(on)</sub> 1	$V_{GS}=10V$ , $I_D=2A$		0.7	1.1	Ω
	R <sub>DS(on)</sub> 2	$V_{GS}=4V$ , $I_D=2A$	1	0.8	1.3	Ω
Forward transadmittance	Y <sub>fs</sub>	$V_{DS}=10V$ , $I_D=2A$ , $f=1MHz$	2	3.4		S
Input capacitance	Ciss			428		pF
Output capacitance	Coss	$V_{DS}=10V$ , $V_{GS}=0$ , $f=1MHz$		97		pF
Feedback capacitance	C <sub>rss</sub>			22		pF
Turn-on time	ton	W -10W I -2A		24		ns
Fall time	t <sub>f</sub>	$V_{GS}=10V, I_{D}=2A$ $V_{DD}=100V, R_{L}=50 \Omega$		36		ns
Turn-off time (delay time)	t <sub>d(off)</sub>	VDD—100V, KL—5012		96		ns

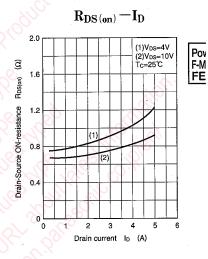


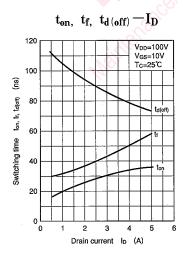












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